

## **650V Super-Junction Power MOSFET**

#### **DESCRIPTION**

#### 650V super-junction Power MOSFET

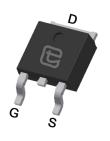
Super-junction power MOSFET is a revolutionary technology for high voltage power MOSFETs, designed according to the SJ principle. The SJ MOSFET is a price-performance optimized product enabling to target cost sensitive applications in Consumer and Lighting markets, designed by Wuxi Unigroup Microelectronics Company.

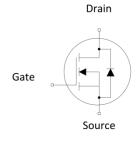
#### **FEATURES**

- Very low FOM  $R_{DS(on)} \times Q_g$
- 100% avalanche tested
- RoHS compliant

#### **APPLICATIONS**

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)







#### **Device Marking and Package Information**

Device	Package	Marking
TPD65R520D	TO-252	65R520D

#### **Key Performance Parameters**

Parameter	Value	Unit
V <sub>DS</sub> @ T <sub>j,max</sub>	650	V
R <sub>DS(on),max</sub>	0.52	Ω
I <sub>D</sub>	7	A
$Q_{g,typ}$	12.5	nC
I <sub>DM</sub>	21	A



<b>Absolute Maximum Ratings</b> $T_C = 25^{\circ}C$ , unless otherwise noted				
Parameter		Symbol	Value	Unit
Drain-Source Voltage (V <sub>GS</sub> = 0V)		V <sub>DSS</sub>	650	V
Continuous Drain Current	$T_{\rm C} = 25^{\rm o}{\rm C}$		7	A
Continuous Diami Current	$T_{\rm C} = 100^{\rm o}{\rm C}$	. I <sub>D</sub>	4	7 ~
Pulsed Drain Current	(note1)	I <sub>DM</sub>	21	А
Gate-Source Voltage		V <sub>GSS</sub>	±30	V
Single Pulse Avalanche Energy (note2)		E <sub>AS</sub>	45	mJ
Avalanche Current		I <sub>AS</sub>	3	А
Power Dissipation		P <sub>D</sub>	62.5	W
Continuous Body Diode Current		I <sub>S</sub>	7	
Pulsed Diode Forward Current (note1)		I <sub>SM</sub>	21	- A
MOSFET dv/dt ruggedness, V <sub>DS</sub> = 0650V		dv/dt	50	V/ns
Reverse diode dv/dt, $V_{DS} = 0650V$ , $I_{SD} \le I_{D}$		dv/dt	5	A/us
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55~+150	°C

Thermal Resistance				
Parameter Symbol Value				
Thermal Resistance, Junction-to-Case	R <sub>thJC</sub>	2	00.004	
Thermal Resistance, Junction-to-Ambient	R <sub>thJA</sub>	62	°C/W	



<b>Specifications</b> $T_J = 25^{\circ}C$ , ur	less othe	rwise noted					
Parameter	Symbol	Test Conditions	Value			Unit	
r di dillocol		Test somations	Min.	Тур.	Max.	Jan.	
Static							
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_{D} = 250\mu A$	650			٧	
Zara Cata Valtaria Dinin Orinna /		$V_{DS} = 650V, V_{GS} = 0V, T_{J} = 25^{\circ}C$			1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 650V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 150°C			100	μA	
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 30V$			±100	nA	
Gate-Source Threshold Voltage	$V_{\rm GS(th)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.5		4.0	>	
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_{D} = 3A$		0.44	0.52	Ω	
Forward Transconductance (Note3)	g <sub>fs</sub>	$V_{DS} = 20V, I_{D} = 3A$		3.6		S	
Dynamic				•			
Input Capacitance	C <sub>iss</sub>	V - 0V		564		pF	
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0V,$ $V_{DS} = 100V,$		22			
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0MHz		0.5			
Total Gate Charge	$Q_g$			12.5		nC	
Gate-Source Charge	$Q_{gs}$	$V_{DD} = 520V, I_{D} = 7A,$ $V_{GS} = 10V$		5			
Gate-Drain Charge	$Q_{gd}$	93 -		3.2			
Turn-on Delay Time	t <sub>d(on)</sub>			52			
Turn-on Rise Time	t <sub>r</sub>	$V_{DD} = 400V, I_{D} = 7A,$		62			
Turn-off Delay Time	t <sub>d(off)</sub>	$R_G = 25\Omega$		84		ns	
Turn-off Fall Time	t <sub>f</sub>			50			
Drain-Source Body Diode Characteris	stics						
Body Diode Voltage	$V_{SD}$	$T_J = 25^{\circ}C, I_{SD} = 7A, V_{GS} = 0V$		0.9	1.2	V	
Reverse Recovery Time	t <sub>rr</sub>			200		ns	
Reverse Recovery Charge	Q <sub>rr</sub>	$V_R = 400V, I_S = 3A,$ $di_F/dt = 100A/\mu s$		1.6		μC	
Peak Reverse Recovery Current	I <sub>rrm</sub>			3.2		А	

### Notes

- 1. Repetitive Rating: Pulse Width limited by maximum junction temperature
- 2.  $V_{DD}$  = 50V,  $R_G$  = 25 $\Omega$ , Starting  $T_J$  = 25 $^{\circ}$ C
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 1%



## **Typical Characteristics** $T_J = 25^{\circ}C$ , unless otherwise noted

I<sub>D</sub>, Drain Current (A)

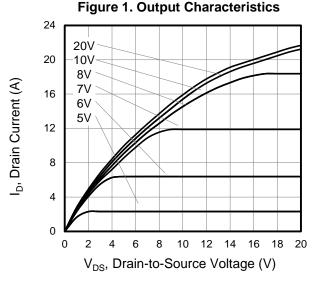


Figure 3 . Body Diode Forward Voltage

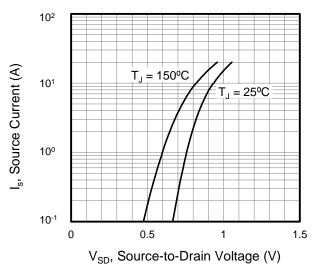
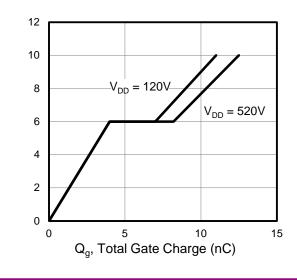


Figure 5. Gate Charge



V<sub>GS</sub>, Gate-to-Source Voltage (V)

Figure 2. Transfer Characteristics

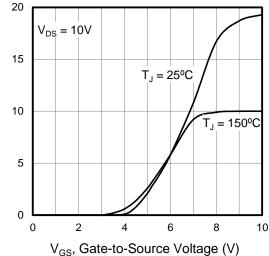


Figure 4. Capacitance

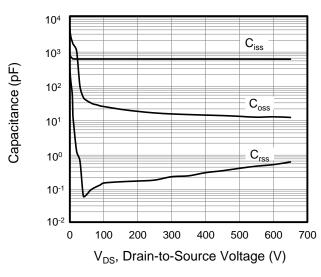
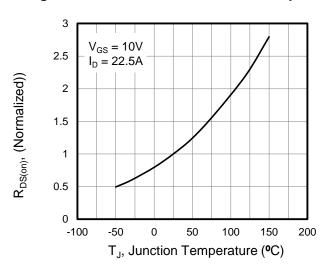


Figure 6. On-Resistance vs. Junction Temperature





# Figure 7. Breakdown voltage vs. Junction Temperature

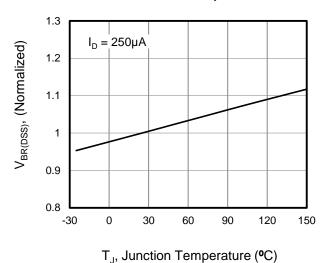
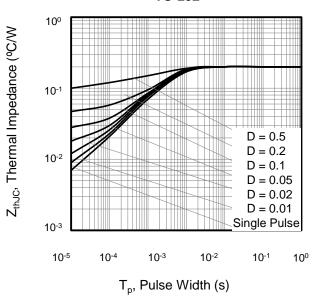


Figure9 . Transient Thermal Impedance for TO-252



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# Figure 8. Threshold Voltage vs. Junction Temperature

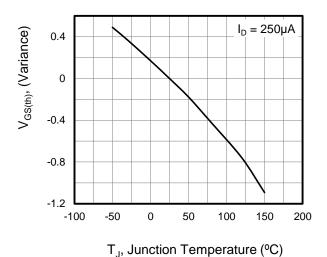


Figure 10. Safe operation area for TO-252

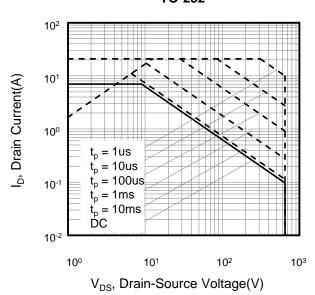


Figure A: Gate Charge Test Circuit and Waveform

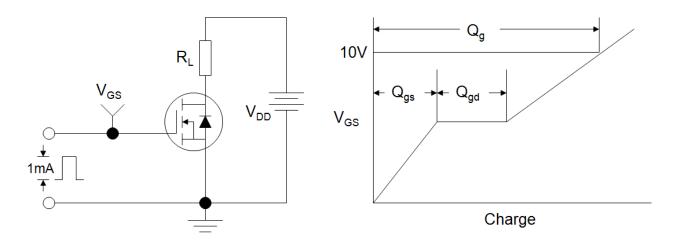


Figure B: Resistive Switching Test Circuit and Waveform

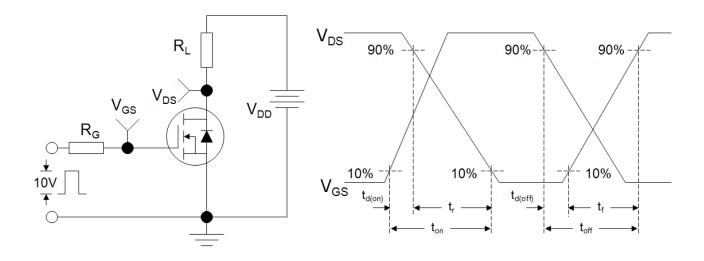
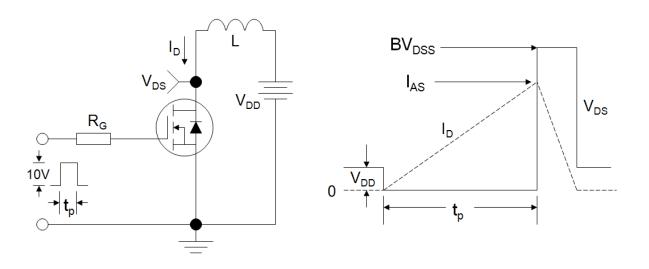
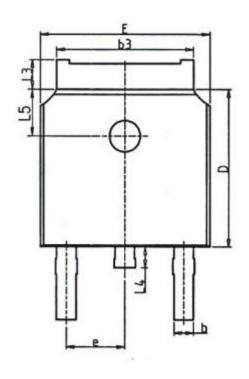


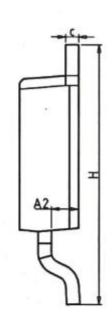
Figure C: Unclamped Inductive Switching Test Circuit and Waveform

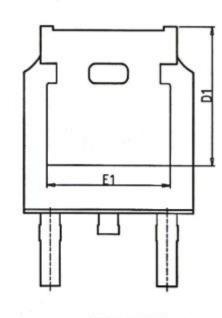


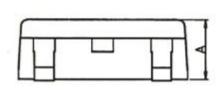


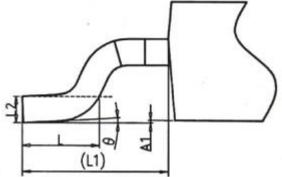
TO-252











Unit:mm					
Symbol	Min.	Nom	Max.		
Α	2.20	2.30	2.40		
A1	0.00	-	0.20		
A2	0.97	1.07	1.17		
b	0.68	0.78	0.90		
b3	5.20	5.33	5.50		
С	0.43	0.53	0.63		
D	5.98	6.10	6.22		
D1	5.30 REF				
E	6.40	6.60	6.80		
E1	4.63	-	-		

Unit:mm					
Symbol	Min.	Nom	Max.		
е		2.286 BSC			
Н	9.40 10.10 10.50				
L	1.38	1.50	1.75		
L1	2.90 REF				
L2	0.51 BSC				
L3	0.88	-	1.28		
L4	-	-	1.00		
L5	1.65	1.80	1.95		
θ	0°	-	8°		



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